

FCC TEST REPORT

APPLICANT Kenxen Digitech Limited

PRODUCT NAME 3 Axis Gimbal

MODEL NAME KGH310

TRADE NAME Kenxen

BRAND NAME Kenxen

FCC ID 2AL8TKGH310

: 47 CFR Part 15 Subpart B STANDARD(S)

2017-08-31 to 2017-09-05 **TEST DATE**

: 2017-09-06 ISSUE DATE

SHENZHEN MORLAB COMMUNICATIONS TECHNOLOGY Co., Ltd.

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	Change History				
Issue	Issue Date Reason for change				
1.0	2017-09-06	First edition			



Test Report Declaration

Applicant	Kenxen Digitech Limited
Applicant Address	Flat/RM 1605,Apec Plaza, 99 Hoi Yuen Road. Kwun Tong, Kowloon, Hong Kong.
Manufacturer	Kenxen Electronic (SZ) Limited
Manufacturer Address	Building A13,Zone D. Minzhu western Industrial Area. Shajing Town .Baoan District. Shenzhen, Guangdong Province. China
Product Name	3 Axis Gimbal
Model Name	KGH310
Brand Name	Kenxen
HW Version	V1.00
SW Version	V1.00
Test Standards	47 CFR Part 15 Subpart B
Test Result	PASS

Tested by

Approved by

Andy Yeh (Ťechnology Director)



1. Technical Information

Note: Provided by applicant

1.1. Applicant Information

Company: Kenxen Digitech Limited

Address: Flat/RM 1605, Apec Plaza, 99 Hoi Yuen Road. Kwun Tong, Kowloon, Hong

Kong.

1.2. Equipment under Test (EUT) Description

EUT Type:	3 Axis Gimbal	
Serial No:	(N/A, marked #1 by test site)	
Hardware Version:	V1.00	
Software Version:	V1.00	

Power supply :	Battery			
	Brand Name: N/A			
	Model No.: FST18650			
	Serial No.: (N/A, marked #1 by test site)			
	Capacity: 2600mAh			
	Rated Voltage:	3.6V		
	Charge Limit:	5V		

NOTE:

- 1. The EUT is a 3 Axis Gimbal which supports ISM 2.4GHz Bluetooth band.
- The EUT is equipped with a Micro USB port which can be connected to ancillary equipments.
- 3. For a more detailed description, please refer to specification or user's manual supplied by the applicant and/or manufacturer.



2. Test Results

2.1. Applied Reference Documents

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart B:

No.	Identity	Document Title
1	47 CFR Part 15	Radio Frequency Devices

Test detailed items/section required by FCC rules and results are as below:

No.	Section	Description	Test Date	Result
1	15.107	Conducted Emission	2017.09.04	PASS
2	15.109	Radiated Emission	2017.09.05	PASS

NOTE: The tests were performed according to the method of measurements prescribed in ANSI C63.4-2014.



Test Conditions Setting 3.

3.1. **Test Mode**

1	The first test mode	(Charging)
	The mat test mode	(Onalging)

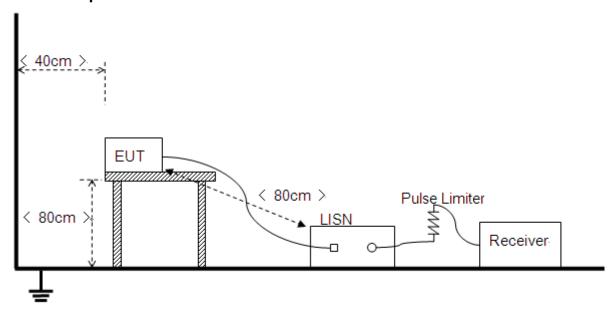
The EUT configuration of the immunity tests is EUT + Battery + Adapter + Camera. In this test mode, the Camera was laid on the EUT, the EUT was connected to an Adapter via the Micro-B USB port and charged by the Adapter, meanwhile, the EUT was working normally as an intentional device.



Test Setup and Equipments List

3.2.1. Conducted Emission

A. Test Setup:



The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides $50\Omega/50\mu H$ of coupling impedance for the measuring instrument. A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

The power strip or extension cord has been investigated to make sure that the LISN integrity inma intained with respect to the impedance characteristics as prescribed in ANSI C63.4-2014 Clause 4.3.

B. Equipments List:

Description	Manufacturer	Model	Serial No.	Cal. Date	Due. Date
Receiver	Narda	PMM 9010	595WX11007	2017.05.17	2018.05.16
LISN	Schwarzbeck	NSLK 8127	812744	2017.05.17	2018.05.16
Pulse Limiter (20dB)	VTSD	9561D	9537	2017.05.17	2018.05.16
Adapter	Vivo	AK901	J11544530988	N/A	N/A



C. Test Software Utilized

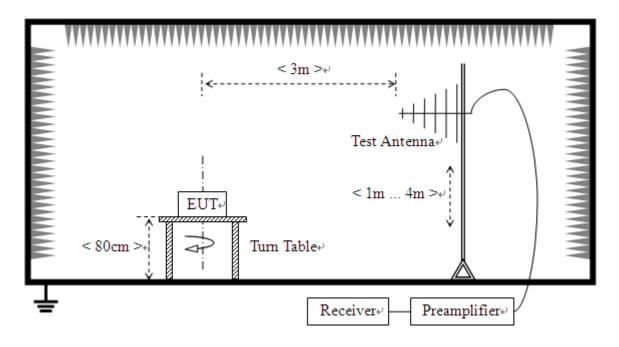
Model	Version Number	Producer	
PMM Emission Suite	Version 2.05	Narda	



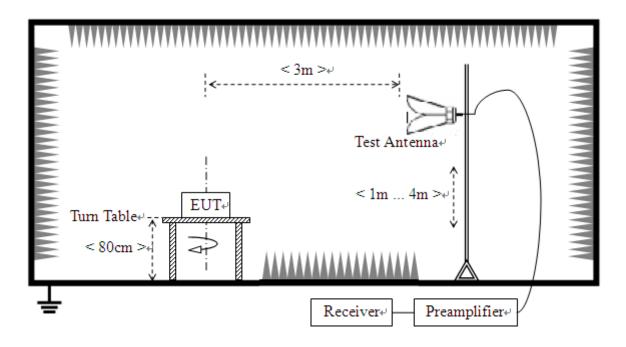
3.2.2. Radiated Emission

A. Test Setup:

1. For radiated emissions from 30MHz to1GHz



2. For radiated emissions above 1GHz





The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on avariable-height antenna master tower.

For the test Antenna:

In the frequency range above 30MHz, Bi-Log Test Antenna (30MHz to 1GHz) and Horn TestAntenna (above 1GHz) are used. Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength. The emission levels at both horizontal and vertical polarizations should be tested.

B. Equipments List:

Description	Manufacturer	Model	Serial No.	Cal. Date	Due. Date
MXE EMI Receiver	Agilent	N9038A	MY54130016	2017.05.17	2018.05.16
Semi-Anechoic Chamber	Changning	9m*6m*6m	N/A	2017.01.11	2018.01.10
Test Antenna - Bi-Log	Schwarzbeck	VULB 9163	9163-274	2016.12.09	2017.12.08
Test Antenna - Horn	Schwarzbeck	BBHA9120C	9120C-384	2017.03.30	2018.03.29
Pre-amplifier	Mini Circuits	S10M100L38 02	46732	2017.07.13	2018.07.12
Adapter	Vivo	AK901	J115445309 88	N/A	N/A

C. Test Software Utilized

Model	Version Number	Producer
MORLAB EMCR V1.2	Version 1.0	MORLAB



47 CFR Part 15B Requirements

Conducted Emission 4.1.

4.1.1. Requirement

According to FCC section 15.107, the radio frequency voltage that is conducted back onto the ACpower line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a $50\mu H/50\Omega$ line impedance stabilization network (LISN).

Frequency range	Conducted	Limit (dΒμV)
(MHz)	Quasi-peak	Average
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
5 - 30	60	50

NOTE:

- a) The limit subjects to the Class B digital device.
- b) The lower limit shall apply at the band edges.
- c) The limit decreases linearly with the logarithm of the frequency in the range 0.15 0.50MHz.

4.1.2. Test Description

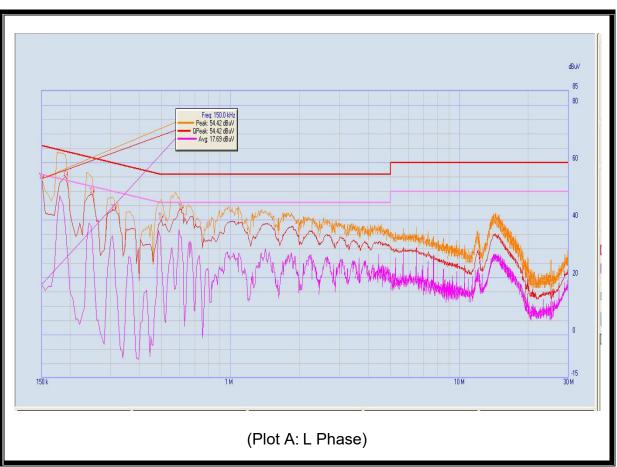
See section 3.2.1 of this report.

4.1.3. Test Result

The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. All test modes are considered, refer to recorded points and plots below.

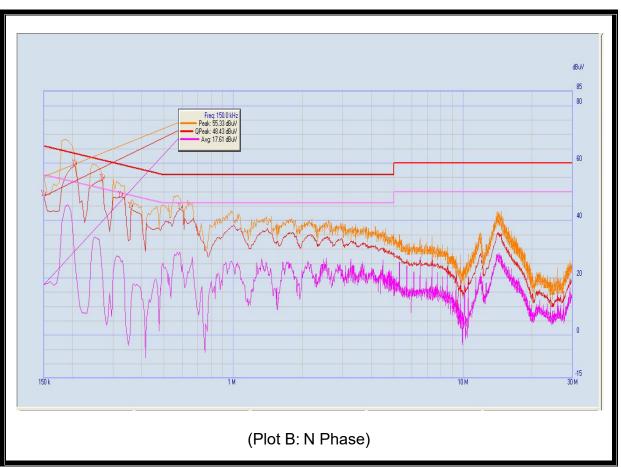
A. Test Plot and Suspicious Points:





No. Fre.		Emission Le	vel (dBµV)	Limit (dBμV)		Power-line	Verdict	
	(MHz)	Quai-peak	Average	Quai-peak	Average			
1	0.15	54.42	17.69	66.00	56.00		PASS	
2	0.19	55.32	36.11	64.86	54.86		PASS	
3	0.25	49.38	32.61	63.14	53.14	Line	PASS	
4	0.31	43.46	29.35	61.43	51.43	Line	PASS	
5	0.50	4048	25.53	56.00	46.00		PASS	
6	0.61	43.81	34.08	56.00	46.00		PASS	





No. Fre.		Emission Level (dBµV)		Limit (dBμV)		Power-line	Verdict	
	(MHz)	Quai-peak	Average	Quai-peak	Average			
1	0.15	48.43	17.61	66.00	56.00		PASS	
2	0.205	59.17	25.52	64.43	54.43		PASS	
3	0.27	54.20	20.93	62.57	52.57	Neutral	PASS	
4	0.325	48.22	25.60	61.00	51.00	Neutrai	PASS	
5	0.36	44.32	12.32	60.00	50.00		PASS	
6	0.59	43.98	28.23	56.00	46.00		PASS	

Result: Pass



4.2. Radiated Emission

4.2.1. Requirement

According to FCC section 15.109 (a), the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency	Frequency Field Strength Limitation at 3m Measurement D		
range (MHz)	(μV/m)	(dBµV/m)	
30.0 - 88.0	100	20log 100	
88.0 - 216.0	150	20log 150	
216.0 - 960.0	200	20log 200	
Above 960.0	500	20log 500	

As shown in FCCsection 15.35(b), for frequencies above 1000MHz, the field strength limits are based on average detector. When average radiated emission measurements are specified in this part, including emission measurements below 1000MHz, there also is a limit on the radio frequency emissions, as measured using instrumentation with a peak detector function, corresponding to 20dB above the maximum permitted average limit for the frequency being investigated unless a different peak emission limit is otherwise specified in the rules.

Note:

- The tighter limit shall apply at the boundary between two frequency range.
- 2) Limitation expressed in dBμV/m is calculated by 20log Emission Level(μV/m).

4.2.2. Test Description

See section 3.2.2 of this report.

4.2.3. Frequency range of measurement

According to 15.33(b)(1), the frequency range of radiated measurement for the EUT is listed in the following table:



Highest frequency generated or used in the device or on which the device operates or tunes (MHz)	Upper frequency of measure- ment range (MHz)
Below 1.705	30. 1000. 2000. 5000. 5th harmonic of the highest frequency or 40 GHz, whichever is lower.

4.2.4. Test Result

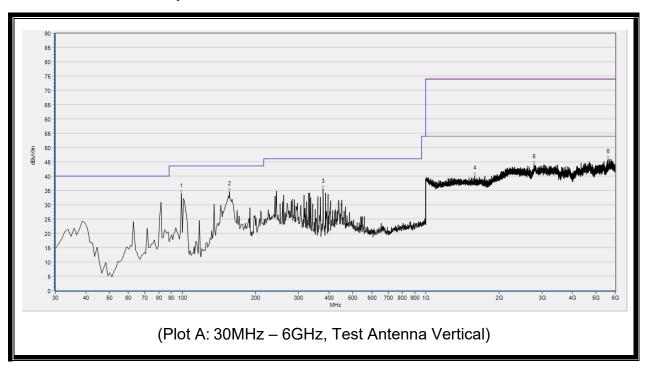
The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to perform the tests. All test modes are considered, refer to recorded points and plots below.

The amplitude of spurious emissions (6GHz-12.5GHz) which are attenuated more than 20 dB below the permissible value need not be reported.

Note: All radiated emission tests were performed in X, Y, Z axis direction, and only the worst axis test condition was recorded in this test report.

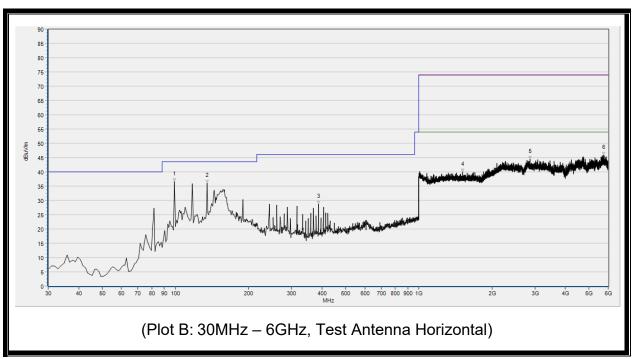


A. Test Plots and Suspicious Points:



No.	Fre.	Pk	QP	AV	Limit-PK	Limit-QP	Limit-AV	ANT	Verdict
	MHz	dBµV/m	dBµV/m	dBµV/m	dBµV/m	dBµV/m	dBµV/m		
1	98.870	N.A.	33.87	N.A.	N.A.	43.50	N.A.	V	PASS
2	156.100	N.A.	34.70	N.A.	N.A.	43.50	N.A.	V	PASS
3	378.230	N.A.	35.45	N.A.	N.A.	46.00	N.A.	V	PASS
4	1588.800	40.27	N.A.	33.05	74.00	N.A.	54.00	V	PASS
5	2785.600	44.12	N.A.	36.97	74.00	N.A.	54.00	V	PASS
6	5606.720	45.83	N.A.	38.61	74.00	N.A.	54.00	V	PASS





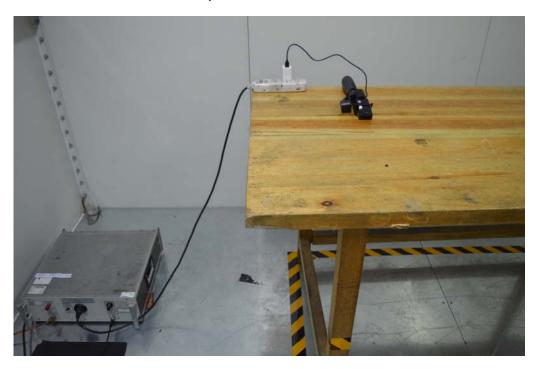
No.	Fre.	Pk	QP	AV	Limit-PK	Limit-QP	Limit-AV	ANT	Verdict
	MHz	dBµV/m	dBµV/m	dBµV/m	dBµV/m	dBµV/m	dBµV/m		
1	98.870	N.A.	36.53	N.A.	N.A.	43.50	N.A.	Н	PASS
2	134.760	N.A.	36.00	N.A.	N.A.	43.50	N.A.	Н	PASS
3	386.960	N.A.	28.70	N.A.	N.A.	46.00	N.A.	Η	PASS
4	1509.867	39.92	N.A.	39.05	74.00	N.A.	54.00	Τ	PASS
5	2861.120	44.41	N.A.	38.54	74.00	N.A.	54.00	Η	PASS
6	5744.960	45.87	N.A.	38.06	74.00	N.A.	54.00	Н	PASS

Result: Pass



Test Setup Photos Annex A

1. Conducted emission main's port front view



2. Conducted emission main's port side view

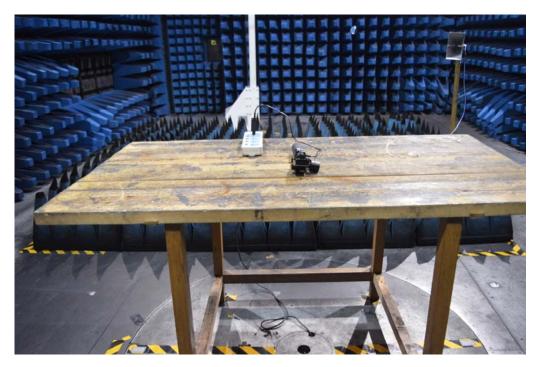




3. Radiated emission (30MHz-1GHz)



4. Radiated emission (above 1GHz)





Test Uncertainty Annex B

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

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Uncertainty of Conducted Emission:	±1.8dB
Uncertainty of Radiated Emission:	±3.1dB



Testing Laboratory Information Annex C

Identification of the Responsible Testing Laboratory

Company Name:	Shenzhen Morlab Communications Technology Co., Ltd.
Department:	Morlab Laboratory
Address:	FL.3, Building A, FeiYang Science Park, No.8 LongChang
	Road, Block 67, BaoAn District, ShenZhen, GuangDong
	Province, P. R. China
Responsible Test Lab Manager:	Mr. Su Feng
Telephone:	+86 755 36698555
Facsimile:	+86 755 36698525

Identification of the Responsible Testing Location

Name:	Shenzhen Morlab Communications Technology Co., Ltd.
	Morlab Laboratory
Address:	FL.3, Building A, FeiYang Science Park, No.8 LongChang
	Road, Block 67, BaoAn District, ShenZhen, GuangDong
	Province, P. R. China

3. Accreditation Certificate

Accredited Testing Laboratory: The FCC designation number is CN1192.

(Shenzhen Morlab Communications Technology Co., Ltd.)

Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature (°C):	15 - 35
Relative Humidity (%):	30 - 60
Atmospheric Pressure (kPa):	86 - 106

***** END OF REPORT *****